

Notice of References Cited

Application/Control No.

10/687,776

Applicant(s)/Patent Under
Reexamination
CHAE ET AL.

Examiner

Michael G. Miller *MBM*

Art Unit

1792

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,176,667 B1	01-2001	Fairbairn et al.	414/217
*	B	US-6,331,384 B1	12-2001	Satoi, Tsunenobu	430/347
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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